

**Notice of References Cited**

Application/Control No.

10/727,025

Applicant(s)/Patent Under  
Reexamination  
QI ET AL.

Examiner

Leonid M Fastovsky

Art Unit

3742

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**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,548,789	04-2003	Rock et al.	219/545
	B	US-6,541,744	04-2003	Von Arx et al.	219/544
	C	US-5,422,462	06-1995	Kishimoto, Yoshio	219/545
	D	US-5,188,766	02-1993	Eiffler, Jorgen	252/500
	E	US-5,171,478	12-1992	Han, Chien-Chung	252/500
	F	US-2003/0091845	05-2003	Pron et al.	428/480
	G	US-2004/0119187	06-2004	Mattes et al.	264/103
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 9924991	05-1999	Great Britain	Adams et al	H01B 1/12
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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